

**Notice of References Cited**

Application/Control No.

10/577,471

Applicant(s)/Patent Under  
Reexamination  
IWAKI ET AL.

Examiner

MICHAEL WILSON

Art Unit

1794

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0086180 A1	07-2002	Seo et al.	428/690
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2005/031798 A2	04-2005	WIPO	Ikeda et al.	H01L
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	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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